

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	2	"20050219914"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 15:25
L2	2	1 and incremental	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 15:26
L3	3355	365/189.01.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 15:26
L5	445	365/185.19.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 15:26
L6	38549	method same ((program or programm\$3) near5 memory)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 15:27
L7	165	6 same ((incremental\$3 or increas\$3) near10 current)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 15:36
L8	18	7 and 5	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 15:28
L9	14866	(leakage adj2 current) near10 ((incremental\$3 or increas\$3) near10 current)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 16:10

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L10	5	"6906961"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 15:39
L11	14787	(leakage adj2 current) near5 ((incremental\$3 or increas\$3) near10 current)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 16:11
L12	7660	(leakage adj2 current) near5 ((incremental\$3 or increas\$3) adj3 current)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 16:11
L13	346	12 near10 memory	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 16:11
L14	33	13 same program\$6	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 16:32
L15	130811	(incremental or increas\$3 or incremental\$3) adj2 current\$3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 16:33
L16	211	15 same (select\$3 adj3 memory adj3 cell)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 16:33
L17	44	16 same (program or programm\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 16:34

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L18	7	17 same equal	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 16:36
L19	5	17 same leakage	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/16 16:47
S1	344	(memory adj3 system) and (memory adj2 array) and (address adj3 interfac\$2) and (control adj3 circuit)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 10:53
S2	28	S1 and decoder and (voltage adj3 generator)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 10:53
S4	3	(memory adj2 array) and (address adj3 interfac\$2) and (control adj3 circuit) and (I/O adj3 interface) and (voltage adj3 generator)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 10:55
S5	32	(memory adj2 array) and (address adj3 interfac\$2) and (control adj3 circuit) and (voltage adj3 generator)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 10:55
S6	18	S5 and "365"/\$7.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 10:55
S12	19483	(programming adj5 memory)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 10:58

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S13	1429	S12 and incremental\$3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 11:07
S14	27	S13 and (current adj3 bit\$1lin\$2)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 11:12
S15	27	S14 and select\$2	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 11:04
S16	6	((("5289411") or ("5572054") or ("6282145"))).PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/08/16 11:06
S17	6	S12 same (incremental\$3 adj5 current)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 11:11
S18	1	S12 same ((increment or incremental or incrementl\$3) adj5 current\$2)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 11:12
S19	229	S12 and ((increment or incremental or incrementl\$3) adj5 current\$2)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 11:12
S21	44	S19 and "365"/\$7.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 14:53

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S22	730	(programm\$3 adj3 memory adj5 cell\$1) and ((incremental or incrementally or increment\$2 or extent or increase) adj5 current)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 14:55
S23	14	(programm\$3 adj3 memory adj5 cell\$1) near10 ((incremental or incrementally or increment\$2 or extent or increase) adj5 current)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 14:59
S24	396	S22 and (selected adj5 memory adj5 cell)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 14:59
S25	258	S24 and substantially	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:00
S26	152	S25 and leakage	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:29
S27	4	S26 and 365/189.01.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:33
S28	131	S26 and "365"/\$7.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:33
S29	108	S28 and detect\$3 and voltage	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:33

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S30	108	S29 and circuit	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:33
S31	80	S30 and (current adj3 source)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:39
S32	4	S28 and 365/189.01,189.02,230.01.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:42
S33	3	tran-hieu.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:42
S34	3	tran-hieu-.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:42
S35	21	tran-hieu-v.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:42
S36	93	tran-hieu-\$.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:45
S37	9	sarin-vishal.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:43

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S38	0	sarin-vishal-\$.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:43
S39	35	lee-dana.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:43
S40	9	lee-dana-\$.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:43
S41	0	(method and programm\$3 and memory and cell and incremental and current and bit\$1in\$2 and selected and leakage).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:47
S42	0	(bit\$1line and leakage and memory and detect\$3 and voltage and array and current and incremental).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:48
S43	0	(memory and array\$1 and cell\$1 and bit\$1in\$2 and circuit and output and voltage and programm\$3 and measure and current and source and detect\$3).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 15:56
S44	1	(memory and array and cell and bit\$1line and first and second and current and source and detector and input and output and voltage and equal and substantially).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/16 16:00